


<b>Search Notes</b>  	<b>Application/Control No.</b>  10813211	<b>Applicant(s)/Patent Under Reexamination</b>  EIKA, TAKURO
	<b>Examiner</b>  Pinheiro, Jason	<b>Art Unit</b>  3709

SEARCHED			
Class	Subclass	Date	Examiner
463	6, 30, 31, 37, 38, 43, 44	1/4/2007	JP

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Name Search	1/4/2007	JP
Assignee Search	1/4/2007	JP
PLUS Search	1/4/2007	JP
Consulted with Kim Nguyen (CLS 463)	1/4/2007	JP
East Text Search (See Attachment)	1/4/2007	JP
Forward/Backward Search	1/4/2007	JP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner